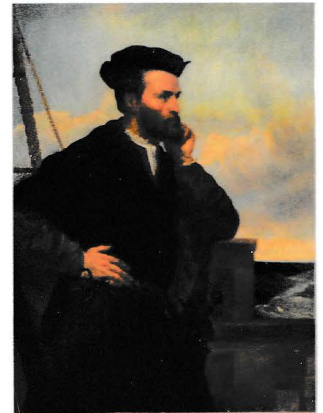


The Jacques Cartier Commemorative Issue of 1934



This exhibit examines the 1934 stamp commemorating the 400th anniversary of the landing of French explorer Jacques Cartier (1491 - 1557) at Québec.



Musée national des beaux-arts du Québec

The exhibit starts with pre-production and development material followed by the basics of the stamp production. A thorough examination of constant varieties is then presented. The final page deals with two non-constant varieties.

A list of the various stamp aspects examined in this exhibit in the order presented follows:

Selecting the Design
Die Proof
Photomechanical Die Proof
Face Value
Date of Issue
The Plates
Specimen

Imperforate
The "Wide Gutter"
"Burr on Shoulder"
"Scarface"
"Line from Hand"
"Line from Sleeve"
Reversed "C" Marginal Marking

"Dot in 4"
"White Flaw After T"
"Line in R"
Hairlines
Re-Entries
Plate Clamps
Misplaced Perfs